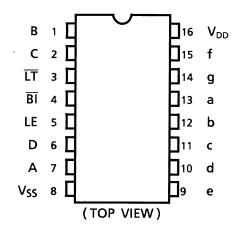
TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

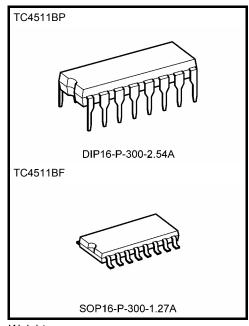
# TC4511BP,TC4511BF

### TC4511B BCD-to-Seven Segment Latch/Decoder/Driver

TC4511B is decoder which converts the input of BCD code into the 7 segment display element driving signal and the output has complementary connection of NPN bipolar transistor and N-channel MOS FET. Therefore, not only capability of directly driving cathode common type LED, this has capability of driving various display elements with simple interface circuits.  $\overline{LT}$  input and  $\overline{BI}$  input are to force all the outputs to be "H" (illuminated) and "L" (not illuminated) respectively regardless of BCD input. As the latch controlled by common LE input is inserted in each of four input lines, static display of dynamic information can be achieved. When an invalid BCD input, "10" or higher is applied, all the outputs become "L" (not illuminated).

### Pin Assignment

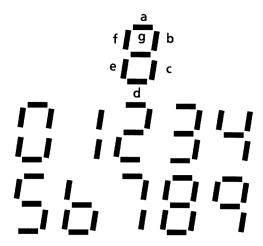




Weight

DIP16-P-300-2.54A : 1.00 g (typ.) SOP16-P-300-1.27A : 0.18 g (typ.)

### **Display**



2007-10-01

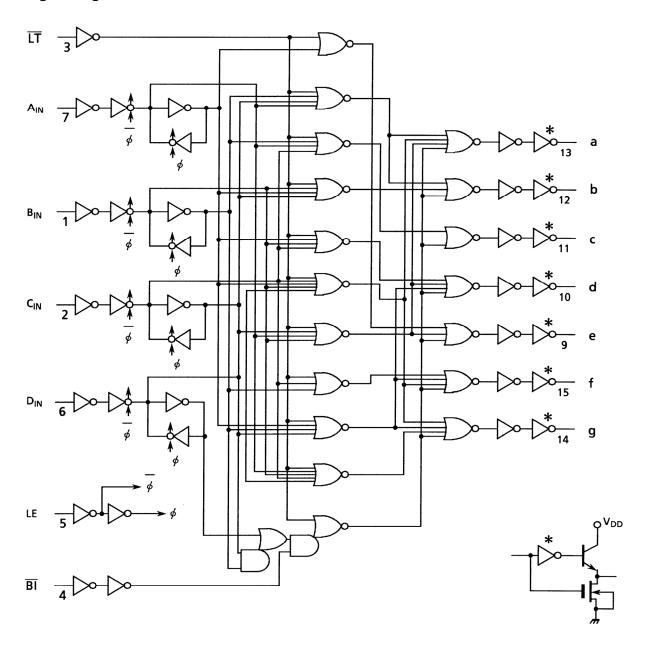
# **Truth Table**

Inputs					Outputs					Display				
LE	BI	ĪΤ	D	С	В	Α	а	b	С	d	е	f	g	Mode
*	*	L	*	*	*	*	Н	Н	Н	Н	Н	Н	Н	8
*	L	Н	*	*	*	*	L	L	L	L	L	L	L	Blank
L	Н	Н	L	L	L	L	Н	Н	Η	Н	Н	Н	L	0
L	Н	Н	L	L	L	Н	L	Н	Η	L	L	L	L	1
L	Н	Н	L	L	Н	L	Н	Н	L	Н	Н	L	Н	2
L	Н	Н	L	L	Н	Н	Н	Н	Η	Н	L	L	Н	3
L	Н	Н	L	Η	L	L	L	Н	Η	L	L	Н	Н	4
L	Н	Н	L	Η	L	Н	Н	L	Η	Н	L	Н	Н	5
L	Н	Н	L	Η	Н	L	L	L	Η	Н	Н	Н	Н	6
L	Н	Н	L	Η	Н	Н	Н	Н	Η	L	L	L	L	7
L	Н	Н	Н	L	L	L	Н	Н	Η	Н	Н	Н	Н	8
L	Н	Н	Н	L	L	Н	Н	Н	Η	L	L	Н	Н	9
L	Н	Н	Н	L	Н	L	L	L	L	L	L	L	L	Blank
L	Н	Н	Н	L	Н	Н	L	L	L	L	L	L	L	Blank
L	Н	Н	Н	Н	*	*	L			Blank				
Н	Н	Н	*	*	*	*	ΔΔ							

<sup>\*:</sup> Don't care

 $\Delta\!\Delta\!$  . Depends upon the BCD code previously applied when LE "L"

# **Logic Diagram**



### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
DC supply voltage	$V_{DD}$	V <sub>SS</sub> - 0.5~V <sub>SS</sub> + 20	V
Input voltage	V <sub>IN</sub>	V <sub>SS</sub> - 0.5~V <sub>DD</sub> + 0.5	٧
Output voltage	V <sub>OUT</sub>	V <sub>SS</sub> - 0.5~V <sub>DD</sub> + 0.5	٧
DC input current	I <sub>IN</sub>	±10	mA
Output high current	I <sub>OH</sub>	-50	mA
Power dissipation	P <sub>D</sub>	300 (DIP)/180 (SOIC)	mW
Operating temperature range	T <sub>opr</sub>	-40~85	°C
Storage temperature range	T <sub>stg</sub>	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

### Operating Range ( $V_{SS} = 0 \text{ V}$ ) (Note)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
DC supply voltage	$V_{DD}$	_	3	_	18	V
Input voltage	V <sub>IN</sub>		0	_	$V_{DD}$	V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ .

# Static Electrical Characteristics ( $V_{SS} = 0 V$ )

Characteristics		Sym-	Test Condition		-40°C		25°C			85°C		
Charac	teristics	bol		V <sub>DD</sub> (V)	Min	Max	Min	Тур.	Max	Min	Max	Unit
				5	4.1	_	4.1	4.41	_	4.2	_	
High-level voltage	output	$V_{OH}$	$ I_{OUT}  < 1 \mu A$ $V_{IN} = V_{SS}, V_{DD}$	10	9.1	_	9.1	9.41	_	9.2	_	V
3			VIN - VSS, VDD	15	14.1		14.1	14.41		14.2		
			  I <sub>OUT</sub>   < 1 μA	5		0.05	_	0.00	0.05	_	0.05	
Low-level voltage	output	$V_{OL}$	$V_{IN} = V_{SS}, V_{DD}$	10	_	0.05	_	0.00	0.05	_	0.05	٧
9-			VIN - VSS, VDD	15	_	0.05	_	0.00	0.05	_	0.05	
			I <sub>OH</sub> = 0 mA		4.10	_	4.10	4.41	_	4.20	_	
			I <sub>OH</sub> = 10 mA	5	3.90	_	3.90	4.25	_	3.90	_	
			I <sub>OH</sub> = 20 mA		3.55	_	3.55	4.19	_	3.30	_	
			$V_{IN} = V_{DD}, V_{SS}$									
			I <sub>OH</sub> = 0 mA		9.10	_	9.10	9.41	_	9.20	_	
Output hig	nh voltage	V <sub>OH</sub>	I <sub>OH</sub> = 10 mA	10	9.00	_	9.00	9.25	_	9.00	_	V
Output mg	gii voltage	VOH	I <sub>OH</sub> = 20 mA		8.70	_	8.70	9.20	_	8.40	_	, v
			$V_{IN} = V_{DD}, V_{SS}$									
			I <sub>OH</sub> = 0 mA		14.10	_	14.10	14.41	_	14.20	_	
			I <sub>OH</sub> = 10 mA	15	14.00	_	14.00	14.26	_	14.00	_	
			I <sub>OH</sub> = 20 mA		13.75	_	13.75	14.21	_	13.50	_	
			$V_{IN} = V_{DD}, V_{SS}$									
			V <sub>OUT</sub> = 0.4 V	5	0.61	_	0.51	1.2	_	0.42	_	
Output lov	v voltago	la.	V <sub>OUT</sub> = 0.5 V	10	1.5	_	1.3	3.2	_	1.1	_	mA
Output lov	v voltage	l <sub>OL</sub>	V <sub>OUT</sub> = 1.5 V	15	4.0	_	3.4	12.0	_	2.8	_	IIIA
			$V_{IN} = V_{DD}, V_{SS}$									
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5	3.5	_	3.5	2.75	_	3.5	_	
Input high	voltago	V <sub>IH</sub>	V <sub>OUT</sub> = 1.0 V, 9.0 V	10	7.0	_	7.0	5.50	_	7.0	_	V
input nign	voitage	VIH	V <sub>OUT</sub> = 1.5 V, 13.5 V	15	11.0	_	11.0	8.25	_	11.0	_	v
			$ I_{OUT}  < 1 \mu A$									
			V <sub>OUT</sub> = 0.5 V, 4.5 V	5	_	1.5	_	2.25	1.5	_	1.5	
Input low	voltaga	\/	V <sub>OUT</sub> = 1.0 V, 9.0 V	10	_	3.0	_	4.5	3.0	_	3.0	V
input low v	vollage	V <sub>IL</sub>	V <sub>OUT</sub> = 1.5 V, 13.5 V	15	_	4.0	_	6.75	4.0	_	4.0	v
			$ I_{OUT}  < 1 \mu A$									
Input	"H" level	l <sub>IH</sub>	V <sub>IH</sub> = 18 V	18		0.1	_	10 <sup>-5</sup>	0.1	_	1.0	^
current	"L" level	I <sub>IL</sub>	V <sub>IL</sub> = 0 V	18		-0.1	_	$-10^{-5}$	-0.1	_	-1.0	μА
			\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	5	_	5	_	0.005	5	_	150	
Quiescent current	supply	$I_{DD}$	$V_{IN} = V_{SS}, V_{DD}$	10	_	10	_	0.010	10	_	300	μА
Current			(Note)	15	_	20	_	0.015	20	_	600	

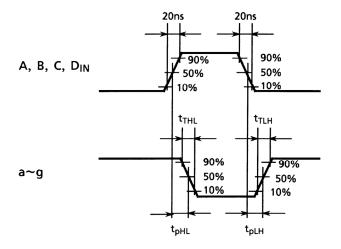
Note: All valid input combinations.

# Dynamic Electrical Characteristics (Ta = 25°C, $V_{SS}$ = 0 V, $C_L$ = 50 pF, $R_L$ = 10 k $\Omega$ )

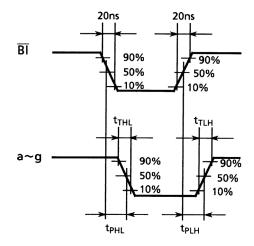
		Test Condition		- Min	Тур.	Max	Unit
Characteristics	Symbol		V <sub>DD</sub> (V)				
Output transition time			5	_	25	80	
Output transition time	tTLH	_	10	_	15	60	ns
(low to high)			15	_	15	50	
Output transition time			5	_	70	200	
(high to low)	t <sub>THL</sub>	_	10	_	35	100	ns
(High to low)			15	_	30	80	
Propagation delay time			5	_	200	1040	
(DATA-OUT)	t <sub>pLH</sub>	_	10	_	90	420	ns
(DATA-001)			15	_	65	300	
Propagation delay time			5	_	230	1040	
(DATA-OUT)	t <sub>pHL</sub>	_	10	_	110	420	ns
(DATA-001)			15	_	80	300	
Propagation delay time			5	_	75	640	
	t <sub>pLH</sub>	_	10	_	45	260	ns
Propagation delay time (BI -OUT)  Propagation delay time (BI -OUT)  Propagation delay time			15	_	35	200	
Propagation delay time			5	_	90	640	
	t <sub>pHL</sub>	_	10	_	50	260	ns
(51 001)			15	_	45	200	
Propagation delay time			5	_	60	300	
(TT-OUT)	t <sub>pLH</sub>	_	10	_	40	150	ns
(1. 33.)			15	_	35	100	
Propagation delay time			5	_	75	300	
(TT-OUT)	t <sub>pHL</sub>	_	10	_	45	150	ns
(21 001)			15	_	35	100	
Propagation delay time			5	_	180	600	
(LE-OUT)	t <sub>pLH</sub>	_	10	_	90	300	ns
( )			15	_	65	250	
Propagation delay time			5	_	230	600	
(LE-OUT)	t <sub>pHL</sub>	_	10	_	110	300	ns
(== + + + + + + + + + + + + + + + + + +			15	_	85	250	
Min pulse time			5	_	40	300	
(LE)	t <sub>W</sub> ∟	_	10	_	20	150	ns
()			15	_	15	120	
Min set-up time			5	_	35	150	
(DATA-LE)	t <sub>SU</sub>	_	10	_	15	70	ns
,			15	_	10	40	
Min hold time			5	_	_	0	
(DATA-LE)	tH	_	10	_	_	0	ns
			15	_	_	0	
Input capacitance	C <sub>IN</sub>	_		—	5	7.5	pF

### **Waveform for Measurement of Dynamic Characteristics**

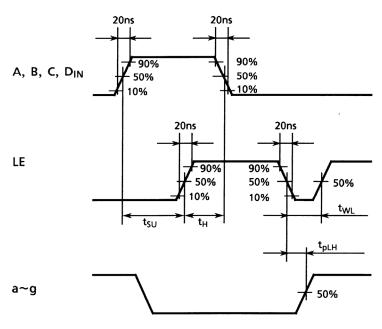
#### Waveform 1



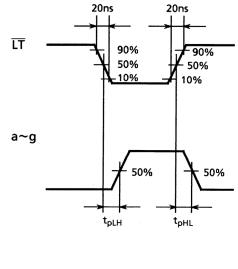
### Waveform 2



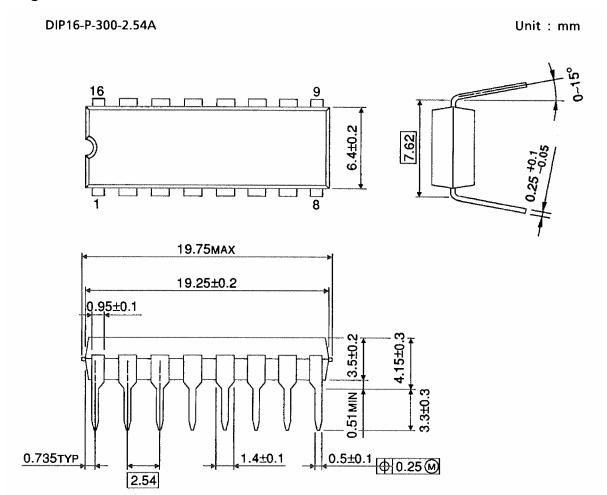
#### Waveform 3



### Waveform 4



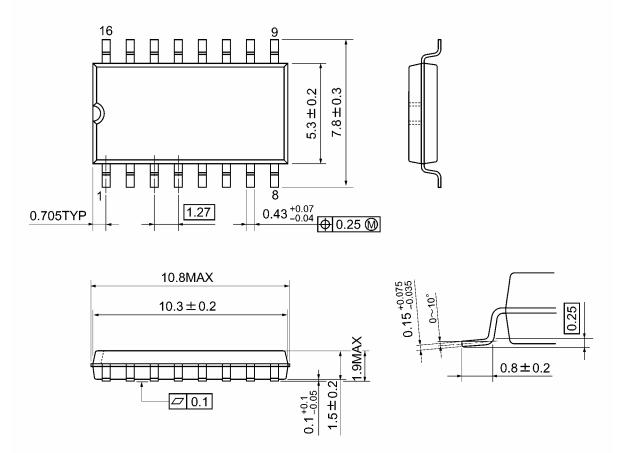
# **Package Dimensions**



Weight: 1.00 g (typ.)

# **Package Dimensions**

SOP16-P-300-1.27A Unit: mm



Weight: 0.18 g (typ.)

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20070701-EN GENERAL

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